MOSFET – Power, Single N-Channel, TDFNW8 DUAL COOL[®] 150 V, 4.45 mΩ, 165 A

NVMTSC4D3N15MC

Features

- Small Footprint (8x8 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

$ \begin{array}{ c c c } \hline \textbf{Symbol} & \hline \textbf{Parameter} & \textbf{Value} & \textbf{Unit} \\ \hline \textbf{V}_{DSS} & Drain-to-Source Voltage & 150 & V \\ \hline \textbf{V}_{GS} & Gate-to-Source Voltage & \pm 20 & V \\ \hline \textbf{I}_D & Continuous Drain Current R_{\theta,JC} (Note 2) & Stady Current R_{\theta,JC} (Note 2) & P_D & Power Dissipation R_{\theta,JC} (Note 2) & Stady Current R_{\theta,JC} (Note 2) & Stade & T_C = 100^{\circ}C & 117 & A \\ \hline \textbf{I}_D & Continuous Drain Current R_{\theta,JC} (Note 2) & Stady Current R_{\theta,JC} (Note 2) & 117 & A \\ \hline \textbf{I}_D & Continuous Drain Current R_{\theta,JA} (Notes 1, 2) & & & & & & & & & & & & & & & & & & $	MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)					
$\begin{array}{c c c c c c c c } \hline V_{GS} & Gate-to-Source Voltage & \pm 20 & V \\ \hline V_{GS} & Gate-to-Source Voltage & \pm 20 & V \\ \hline I_D & Continuous Drain \\ Current R_{\theta JC} (Note 2) & Steady \\ \hline P_D & Power Dissipation \\ R_{\theta JC} (Note 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JC} (Note 2) & Steady \\ \hline P_D & Power Dissipation \\ R_{\theta JC} (Note 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Note 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Note 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & Steady \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) & T_A = 25^{\circ}C, t_p = 10 \ \mu S & 900 & A \\ \hline I_{J,T} T_{stg} & Operating Junction and Storage Temperature \\ \hline I_A & Source Current (Body Diode) & 243 & A \\ \hline E_{AS} & Single Pulse Drain-to-Source Avalanche \\ Energy (I_L = 14.1 \ A_{pk,}) & T_L & Lead Temperature Soldering Reflow for & 260 \ \circ C \\ \hline \end{array}$	Symbol	Parar	neter		Value	Unit
$\begin{array}{ c c c c c } \hline I_{DG} & Continuous Drain \\ Current R_{\theta JC} (Note 2) \\ \hline P_D & Power Dissipation \\ R_{\theta JC} (Note 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta JC} (Note 2) \\ \hline P_D & Power Dissipation \\ R_{\theta JC} (Note 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta JC} (Note 2) \\ \hline P_D & Power Dissipation \\ R_{\theta JC} (Note 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) \\ \hline P_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) \\ \hline P_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \\ \hline I_A & Source Current (Body Diode) \\$	V _{DSS}	Drain-to-Source Voltag	ge		150	V
$ \begin{array}{ c c c c } \hline C & Current R_{\theta,JC} (Note 2) \\ \hline P_D & Power Dissipation \\ R_{\theta,JC} (Note 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta,JC} (Note 2) \\ \hline P_D & Power Dissipation \\ R_{\theta,JC} (Note 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta,JA} (Note 2) \\ \hline I_D & Continuous Drain \\ Current R_{\theta,JA} (Notes 1, 2) \\ \hline P_D & Power Dissipation \\ R_{\theta,JA} (Notes 1, 2) \\ \hline P_D & Power Dissipation \\ R_{\theta,JA} (Notes 1, 2) \\ \hline P_D & Continuous Drain \\ Current R_{\theta,JA} (Notes 1, 2) \\ \hline P_D & Power Dissipation \\ R_{\theta,JA} (Notes 1, 2) \\ \hline P_D & $	V _{GS}	Gate-to-Source Voltag	Gate-to-Source Voltage			V
$\begin{array}{ c c c c } \hline B_{R \cup C} (Note 2) & \ & \ & \ & \ & \ & \ & \ & \ & \ & $	Ι _D			T _C = 25°C	165	A
$\begin{array}{ c c c c c } \hline Current $R_{\theta JC}$ (Note 2) \\ \hline P_D & Power Dissipation $R_{\theta JC}$ (Note 2) \\ \hline I_D & Continuous Drain $Current $R_{\theta JA}$ (Notes 1, 2) \\ \hline P_D & Power Dissipation $R_{\theta JA}$ (Notes 1, 2) \\ \hline I_D & Continuous Drain $Current $R_{\theta JA}$ (Notes 1, 2) \\ \hline I_D & Continuous Drain $Current $R_{\theta JA}$ (Notes 1, 2) \\ \hline I_D & Continuous Drain $Current $R_{\theta JA}$ (Notes 1, 2) \\ \hline P_D & Power Dissipation $R_{\theta JA}$ (Notes 1, 2) \\ \hline P_D & Power Dissipation $R_{\theta JA}$ (Notes 1, 2) \\ \hline P_D & Power Dissipation $R_{\theta JA}$ (Notes 1, 2) \\ \hline I_D & Continuous Drain $Current $R_{\theta JA}$ (Notes 1, 2) \\ \hline P_D & Power Dissipation $R_{\theta JA}$ (Notes 1, 2) \\ \hline I_D & Pulsed Drain $Current $T_A = 25^{\circ}C$, $t_p = 10 μs $900 A \\ \hline T_J, $T_{stg} $ Operating Junction and Storage Temperature $Range$ $-55 to $+175$ C \\ \hline I_S & Source Current (Body Diode) $243 A \\ \hline E_{AS} $ Single Pulse Drain-to-Source Avalanche $Single Pulse Drain-to-Source Avalanche $Current $Range C	P _D				292	W
$\begin{array}{ c c c c c } \hline R_{\theta JC} (Note 2) & & & & & & \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & Steady \\ \hline P_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) & & & & & \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & & & & & \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & & & & \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) & & & & \\ \hline P_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) & & & & \\ \hline I_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) & & & \\ \hline I_D & Pulsed Drain Current & T_A = 25^{\circ}C, t_p = 10 \ \mu s & 900 & A \\ \hline I_J, T_{stg} & Operating Junction and Storage Temperature \\ Range & & & \\ \hline I_S & Source Current (Body Diode) & & & \\ \hline I_L & Lead Temperature Soldering Reflow for & & & \\ \hline C_L & Continuous Drain \\ \hline Current R_{Range} & & & \\ \hline C_L & Continuous Drain \\ \hline C_L & Continuous \\ \hline C_L & Conti$	ID		,		117	A
$ \begin{array}{ c c c c c } \hline Current R_{\theta JA} \\ (Notes 1, 2) \end{array} & State & A & \\ \hline P_D & Power Dissipation \\ R_{\theta JA} (Notes 1, 2) \end{array} & State & A & \\ \hline D & Continuous Drain \\ Current R_{\theta JA} \\ (Notes 1, 2) \end{array} & Steady \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} \\ (Notes 1, 2) \end{array} & Steady \\ \hline T_A = & & & & & & & & & & & & & & & & & & $	P _D				146	W
$ \begin{array}{ c c c c c } \hline B_{\theta JA} (Notes 1, 2) & & & & & \\ \hline I_D & Continuous Drain \\ Current R_{\theta JA} (Notes 1, 2) & & & \\ \hline I_{00^{\circ}C} & & & \\ \hline I_{00^{\circ}C}$	Ι _D	Current R _{0JA}	,	T _A = 25°C	23	A
$\begin{tabular}{ c c c c c c } \hline Current $R_{\theta JA}$ (Notes 1, 2) & State & 100°C & & & & & & & & & & & & & & & & & & &$	PD				5	W
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Ι _D	Current $R_{\theta JA}$			16	A
$ \begin{array}{c c} T_J, T_{stg} & \mbox{Operating Junction and Storage Temperature} \\ Range & -55 to \\ +175 & \mbox{+}175 & \mbox{+}175 & \mbox{-}55 to \\ +175 & \mbox{+}175 & \mbox{-}175 & \mbo$	PD				3	W
Range+175IsSource Current (Body Diode)243A E_{AS} Single Pulse Drain-to-Source Avalanche Energy (I_L = 14.1 A _{pk} ,)3390mJ T_L Lead Temperature Soldering Reflow for260°C	I _{DM}	Pulsed Drain Current	T _A = 25°C	C, t _p = 10 μs	900	А
$ \begin{array}{c c} E_{AS} & Single Pulse Drain-to-Source Avalanche \\ Energy (I_L = 14.1 A_{pk,}) \end{array} & \begin{array}{c} 3390 \\ \end{array} & \begin{array}{c} mJ \\ \end{array} \\ \end{array} \\ \hline T_L & Lead Temperature Soldering Reflow for \\ \end{array} & \begin{array}{c} 260 \\ \end{array} & \begin{array}{c} ^{\circ}C \end{array} \\ \end{array} $	T _J , T _{stg}					°C
Energy ($I_L = 14.1 A_{pk,}$)T _L Lead Temperature Soldering Reflow for260°C	۱ _S	Source Current (Body I	Diode)		243	Α
	E _{AS}				3390	mJ
	TL				260	°C

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 in² pad size, 1 oz Cu pad.

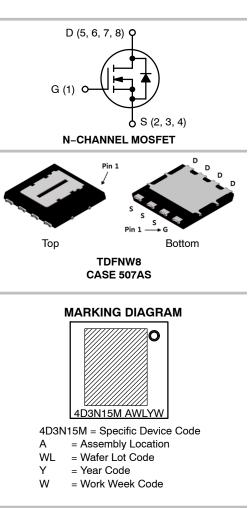
2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted



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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
150 V	$4.45~\mathrm{m}\Omega$ @ 10 V	165 A



ORDERING INFORMATION

Device	Package	Shipping [†]
NVMTSC4D3N15MC	TDFNW8 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Symbol	Parameter	Мах	Unit
$R_{ extsf{ heta}JC}$	Junction-to-Case - Steady State (Note 2)	0.5	°C/W
$R_{ extsf{ heta}JC}$	Junction-to-Case Top (Note 2)	0.8	
$R_{ heta JA}$	Junction-to-Ambient - Steady State (Note 2)	28	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test C	Test Condition		Тур	Max	Unit
OFF CHARACT	ERISTICS						
V _{(BR)DSS}	Drain – to – Source Breakdown Voltage	V_{GS} = 0 V, I _D =	250 μΑ	150	-	-	V
$V_{(BR)DSS}$ / T_J	Drain – to – Source Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, ref to 25°C		-	49.84	_	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} = 0 V, V _{DS} = 120 V	$T_J = 25^{\circ}C$	-	-	1	μA
		V _{DS} = 120 V	$T_J = 125^{\circ}C$	-	-	10	μA
I _{GSS}	Gate - to - Source Leakage Current	$V_{DS} = 0 V, V_{GS}$	= ±20 V	-	-	±100	nA
ON CHARACTE	ERISTICS (Note 3)						

V _{GS(TH)}	Gate Threshold Voltage	V_{GS} = V_{DS} , I_D = 521 μ A	2.5	3.6	4.5	V
V _{GS(TH)} / T _J	Negative Threshold Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, ref to 25°C	-	-9.93	-	mV/°C
R _{DS(on)}	Drain – to – Source On Resistance	V _{GS} = 10 V, I _D = 95 A	-	3.4	4.45	mΩ
9 FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 95 \text{ A}$	-	177	-	S
R _G	Gate-Resistance	$T_A = 25^{\circ}C$	-	1.1	_	Ω

CHARGES & CAPACITANCES

C _{ISS}	Input Capacitance	$V_{GS} = 0 V, f = 1 MHz,$	-	6514	-	pF
C _{OSS}	Output Capacitance	V _{DS} = 75 V	-	1750	-	
C _{RSS}	Reverse Transfer Capacitance		-	12.5	-	
Q _{G(TOT)}	Total Gate Charge	$V_{GS} = 10 \text{ V}, V_{DS} = 75 \text{ V},$	-	79	-	nC
Q _{G(TH)}	Threshold Gate Charge	l _D = 95 A	-	21	-	
Q _{GS}	Gate-to-Source Charge		-	36	-	
Q _{GD}	Gate-to-Drain Charge		_	11	_	
V _{GP}	Plateau Voltage		-	5.8	_	

SWITCHING CHARACTERISTICS, V_{GS} = 10 V (Note 3)

t _{d(ON)}	Turn – On Delay Time	$V_{GS} = 10 \text{ V}, V_{DS} = 75 \text{ V},$	-	38	-	ns
t _r	Rise Time	I _D = 95 A, R _G = 6 Ω	-	11	-	
t _{d(OFF)}	Turn – Off Delay Time		-	48	-	
t _f	Fall Time]	-	8	-	

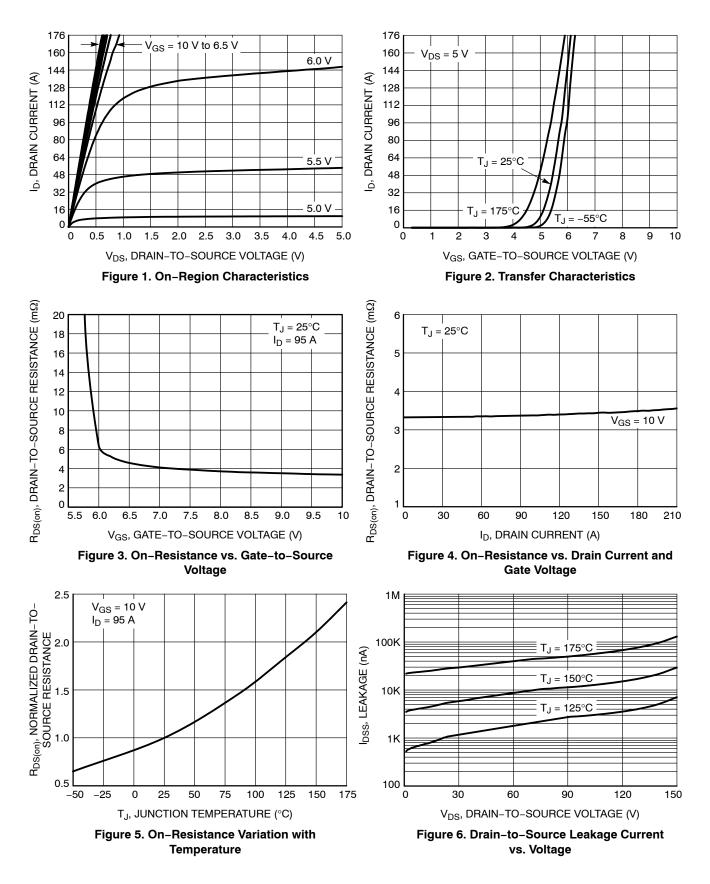
DRAIN-SOURCE DIODE CHARACTERISTICS

V _{SD}	Forward Diode Voltage	V _{GS} = 0 V, I _S = 95 A	$T_J = 25^{\circ}C$	-	0.86	1.2	V
		IS = 95 A	T _J = 125°C	-	0.80	-	
t _{RR}	Reverse Recovery Time	$V_{GS} = 0 V, dI_{S}/c$	dt = 100 A/µs,	-	85	-	ns
ta	Charge Time	I _S = 95 A		-	58	-	
t _b	Discharge Time			-	38	-	
Q _{RR}	Reverse Recovery Charge			-	194	_	nC

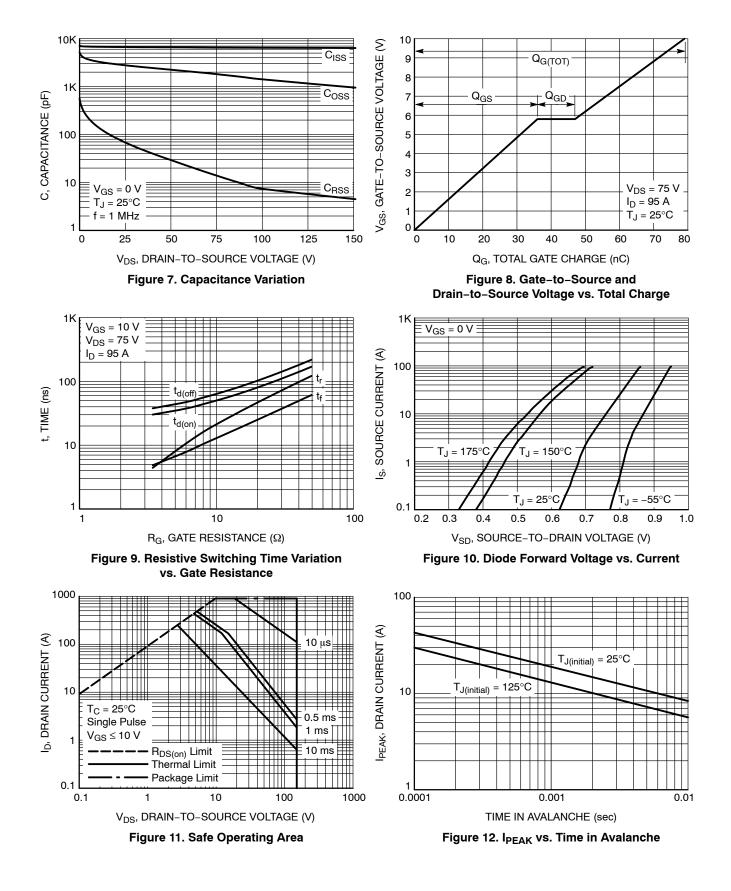
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Switching characteristics are independent of operating junction temperatures

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TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

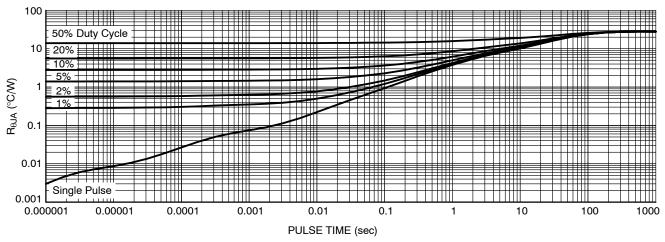
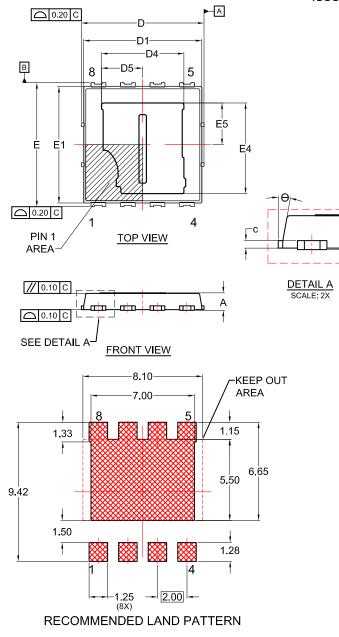
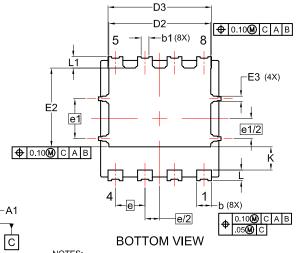


Figure 13. Thermal Characteristics

PACKAGE DIMENSIONS

TDFNW8 8.3x8.4, 2P CASE 507AS **ISSUE A**





- NOTES:
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS
- WELL AS THE TERMINALS.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
 SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM	N	IILLIMET	ERS
DIM	MIN.	NOM.	MAX.
А	0.82	0.92	1.02
A1	0.00		0.05
b	0.90	1.00	1.10
b1	0.43	0.53	0.63
с	0.23	0.28	0.33
D	8.20	8.30	8.40
D1	7.90	8.00	8.10
D2	6.80	6.90	7.00
D3	6.90	7.00	7.10
D4	5.47	5.57	5.67
D5	2.69	2.79	2.89
Е	8.30	8.40	8.50
E1	7.80	7.90	8.00
E2	5.24	5.34	5.44
E3	0.25	0.35	0.45
E4	6.03	6.13	6.23
E5	2.72	2.82	2.92
е		2.00 BS	С
e/2		1.00 BS	С
e1		2.70 BS	С
e1/2		1.35 BS	С
к	1.50	1.57	1.70
L	0.64	0.74	0.84
L1	0.67	0.77	0.87
θ	0°		12°

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